



Development of Carbonless MRPC for MARQ Experiment in Japan

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2024/09/10

Outline

- Requirement of MARQ RPC
- Carbonless RPC prototype
- Beam test results
- Summary and to do



Requirement of MARQ RPC



- MARQ (Multi-purpose Analyzer for Resonance and Quark dynamics Spectrometer)
- Study charmed-baryon spectroscopy and proton GPD.
- Experimental site is located at J-PARC in Tokai, Japan.
- RPC will be used as TOF wall and Muon wall.

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Development and Issues



- Design of Carbonless RPC prototype for MARQ :
- Carbonless electrode : The supply of carbon tape used for BGO-egg RPC and LEPS2 RPC is no longer available. We tested different material for electrode and also develop carbonless RPC (this talk).
- Solid silicon gasket : The glue seal was used for BGO-egg RPC and LEPS2 RPC. However, we suffered from the gas leak due to the damage of transportation of MRPC. New design adopts mechanical seal with solid silicon gasket which allows us to have more reliable gas seal. Furthermore, a thinner chamber with thickness less than 10mm is possible with silicon gasket.
- 3 Multilayer PCB : Multilayer PCB serve as part/cover of gas chamber, so-called self-seal MRPC. It consists of both HV copper array and readout strip.
- Mylar spacer : The aging effect of MRPC is caused by the chemical deposition of the gas along the fishing line. Mylar spacer is employed and tested.

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Carbonless MRPC Prototype (1)



- **RPC** specification
- Size of chamber 25cm * 25cm * 7.8mm
- 1 stack * 5gaps * 260um gap * 400um glass
- Active area 20cm*20cm
- Gas : R134a/iso-Butane/SF6 = 90/5/5
- 16ch thin readout strip with 4mm*20cm

- Carbonless electrode
- Solid silicon gasket
- **Multilayer PCB**
- Mylar spacer
- Self-seal MRPC
- Simple production procedure
- Read both positive and negative signals.

Carbonless MRPC Prototype (2)



Multilayer PCB (~2 mm)					
Layer	Name	Material	Thickness		
	Resistor solder	copper	0.018 mm		
	Dielectric	FR4	0.203 mm		
	GND	copper	0.018 mm		
	Dielectric	FR-4	1.500 mm		
	Readout strip	copper	0.018 mm		
	Dielectric	FR-4	0.203 mm		
	HV pad	copper	0.018 mm		

• Through hold from top layer to bottom layer.

• Conductive tape required to have proper connection between glass and PCB.

- 2mm thickness multilayer PCB includes
- (1) Carbonless = HV copper pad array with 100kOhm resistor connected to reduce current draw.
- (2) Though holes connect the top later and bottom layer to apply HV from outside to inside.
- (3) 3M conductive tape is required between PCB and glass to have HV properly applied.
- (4) Readout strips is 1.5mm away from GND to have larger induced signal.
- (5) GND is designed to have better transmission line calculation for impedance match.
- (6) Thick PCB to avoid HV breakdown inside PCB.

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Carbonless MRPC Prototype (3)



GND Layer to Reduce Signal Reflection



Mylar Spacer/Sticker





- Mylar spacer/sticker is factory produced from Panel Group, Taiwan.
- Size of one mylar spacer is 2mm-diameter dot with 0.26mm thickness.
- It can be customized to different thickness, shape, and material.
- thickness : min = 0.07mm, max = 1.5mm
- diameter : min = 1mm
- distance : min = 1mm
- Teflon, Mylar, Kapton are all possible.

Electronics

Amp : BAG2866/ 2 stages / BW up to 2G / TW



Dis: ADCMP572 / TOT / 10ps jitter / TW



HRTDC / 25ps jitter / JP



Commercial chips are used for Amp and discriminator. HRTDC is newly developed and testing.

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Cosmic Ray Signals



- Reasonable cosmic ray signals observed.
- Both positive and negative signals are sharp and fast.

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Beam Test @ SPring-8



- Beam test was performed with electron beam with low rate $< 3kHz/cm^2$.
- Time resolution includes jitter of T0 ~ 15ps.



Best Test Results : HV Scan



>13kV, Poor slewing correction

- Positive ang negative signals have the same performance.
- 95% efficiency and 95 ps time resolution.
 (Goal : >99% efficiency and 70 ps time resolution)

Best Test Results : HV Scan







 Time-over-threshold (TOT) is used to perform the slewing correction.

• Why only 95% efficiency? Due to TDC limitation, the narrow signals from the Resistive Plate Chamber (RPC) can't be detected effectively. The plan is to upgrade the discriminator to ensure that the logic signals it produces are always longer than 1 ns, which would allow the TDC to detect these signals properly.

• Why only 95ps time resolution? The presence of multiple peak TOT signals suggests that noise, possibly from a ground loop, is affecting the measurements. To improve the time resolution, we will address this noise issue.

Beam Test Results : Intrinsic Resolution of Electronics

Time resolution of "Positive-Negative"



• $\sigma_{[Pos-Neg]}^2 = 2 * [\sigma_{Eletro}^2 + (1-C)\sigma_{RPC}^2]$

C is the correlation between positive and negative signals.

If C = 1, $\sigma_{Electro} = \sigma_{[Pos-Neg]}/\sqrt{2}$ (if positive signal and negative signal are identical.)

One could possibly access the intrinsic jitter of FEE from this method.

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Best Test Results : Position Scan

Along Strip



Along Strip.

- #1 pad : 92%, 102.78 ± 2.16 ps
- #4 pad : 96%, 112.36 ± 2.15 ps
- #9 pad : 94%, 100.68 ± 2.10 ps
- #9 & #10 : 94%, 97.18 ± 1.85 ps
- ➔ No trend observed.
- → 1mm gap between HV pad is fine.

Between Strips

- 12^{th} strip : 94%, 93.82 \pm 1.87 ps
- Between : 80%, 135.33 \pm 3.52 ps
- 13^{th} strip : 92%, 105.23 ± 2.27 ps
- → Eff. Drops between strips.
- → Gap size of HV pads between strips is 4mm.
- → 4mm gas is too large. We will reduce the gap between HV pad.

Best Test Results : Stability

Efficiency



- Efficiency drops after two days operation in hall.
- We suspect there might be current leakage in the multilayer PCB. To address this, we plan to increase the PCB thickness to 5mm (PCB production limitation is 7mm).

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Summary and To Do

- We have developed a carbonless RPC (Resistive Plate Chamber) prototype for the future MARQ project at J-PARC since the carbon tape supply is nolonger available. Our efforts have focused on addressing several issues: finding alternative electrode materials, preventing gas leaks from glue seals, and mitigating the aging effects of fishing line. To tackle these challenges, we experimented with various innovations, including multilayer PCBs, solid silicon gaskets, and mylar spacers.
- The prototype has demonstrated around 95% efficiency and a time resolution of approximately 95 ps. However, some challenges remain that need further investigation.
- Concerning the stability issue, there is a suspicion of current leakage in the multilayer PCB. To address this, we plan to increase the PCB thickness and conduct a beam test in November.
- To enhance efficiency, we will upgrade the discriminator design to ensure that the Time-Over-Threshold (TOT) exceeds 1 ns. Additionally, to improve time resolution, we will work on better noise control to enhance the quality of slewing correction.

Backup



Options of Electrode Material

Candidates and Milestones

Assembl Endurance **Candidate Name Composition** in hand y HV test CR test test Beam test (Lyon) Carbon ink Mylar **72 hours O** Glass Nanocarbon dispersed **2 CS-6301** polysiloxane Mylar **③ KP-8348-1 Fluoropolymer-base 72 hours O** conductive coating Glass Black \mathbf{X} **Polythiophene-base** No dark (4) SEPLEGYDA conductive polymer Mylar current X No dark (**Portugal**) Mylar current 6 Tanimura **Carbon tape** newly done done before

considering 2 additional candidates (Fluoropolymer-base conductive coating).

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As of 2024/08/23

GND Layer To Have Better Transmission Line Calaultion

Typical RPC is designed to be like Transmission Line (TL), However not in typical PCB Planar TL structure.

- A. No metal ground plan along with signal strip,
- B. Two signal strips in parallel, one strip for +HV Carbon signal induction, the other for -HV carbon signal induction.

Not so easy to practice "Impedance match" like most of strip type TL. +

Multiple reflected signals often overlap with original signal, degrades timing measurement quality.



3M Conductive Tape







3M[™] XYZ-Axis Electrically Conductive Acrylic Double Side Coated Tape 9850

Product Description

3M[™] XYZ-Axis Electrically Conductive Acrylic Double Side Coated Tape (e-Conductive DC Tape) 9850 is an isotropically and electrically conductive tape. It consists of conductive acrylic Pressure Sensitive Adhesive (PSA) loaded with conductive nonwoven. This Electrically Conductive Acrylic Double Side Coated Tape 9850 offers both high adhesion and very good electrical conductivity. The conductive nonwoven in 3M[™] e-Conductive DC Tape 9850 also provides better handling characteristics and prevents oozing issue. 3M e-Conductive DC Tape 9850 conducts electricity (current) flowing through the thickness (Z-axis) and the bone-line of the adhesive (X-Y axis), it is an ideal PSA designed to most desired surface for grounding, EMI shielding and EMI gasket attachment... etc. in electronics or electrical devices application. It can be also used for many types of metal foils laminated to provide customized shielding, grounding or e-Conductive purpose reinforcing solutions. This tape may be used for attaching conductive fabric/foam core EMI gaskets to electronic cabinetry as well.

3M™ XYZ-Axis Electrically Conductive Acrylic Double Side Coated Tape 9850

Properties	Typical Value	
Type of carrier	Conductive nonwoven	
Type of Adhesive	Conductive acrylic adhesive	
Release Liner	White Polycoated Kraft Paper printed with 3M logo in red color.	
Thickness		
Carrier plus Adhesive	50 um	
Liner	150 um	
Adhesion strength 1	1500 gf/inch	
Surface Resistance of Adhesive 2	< 0.1 Ω/	
Electrical resistance through adhesive 3	< 0.5 Ω	
Electrical resistance through adhesive 4	< 0.05 Ω/inch ²	
Foot note 1. Test method ref. to ASTM D 1000 peeling force section		
2.		

Factory produced

Specification of Amplifier Chip



RF3376

General Purpose Amplifier

Package Style: SOT8



Features

- DC to >6000MHz Operation
- Internally Matched Input and Output
- 22dB Small Signal Gain
- +2.0dB Noise Figure
- +11dBm Output P1dB
- Useable with 5V Supply

Applications

- Basestation Applications
- Broadband, Low-Noise Gain Blocks
- IF or RF Buffer Amplifiers
- Driver Stage for Power Amplifiers
- Final PA for Low-Power Applications
- High Reliability Applications



Functional Block Diagram

Product Description

The RF3376 is a general purpose, low-cost RF amplifier IC. The device is manufactured on an advanced Gallium Arsenide Heterojunction Bipolar Transistor (HBT) process, and has been designed for use as an easily-cascadable 50 Ω gain block. Applications include IF and RF amplification in wireless voice and data communication products operating in frequency bands up to 6000 MHz. The device is self-contained with 50Ω input and output impedances and requires only two external DCbiasing elements to operate as specified.

https://www.mouser.com/datasheet/2/412/f33 76 data sheet-973800.pdf

BGA2866

MMIC wideband amplifier

Rev. 4 — 13 July 2015

Product data sheet

1.1 General description

Silicon Monolithic Microwave Integrated Circuit (MMIC) wideband amplifier with internal matching circuit in a 6-pin SOT363 plastic SMD package.

1.2 Features and benefits

- Input internally matched to 50 Ω
- A gain of 23.2 dB at 250 MHz increasing to 24.3 dB at 2150 MHz
- Output power at 1 dB gain compression = 4 dBm
- Supply current = 17.4 mA at a supply voltage of 5 V
- Reverse isolation > 32 dB up to 2150 MHz
- Good linearity with low second order and third order products
- Noise figure = 3.8 dB at 950 MHz
- Unconditionally stable (K > 1)
- No output inductor required

1.3 Applications

- LNB IF amplifiers
- General purpose low noise wideband amplifier for frequencies between DC and 2.2 GHz

Pin	Description	Simplified outline	Graphic symbol
1	Vcc		
2, 5	GND2	6 5 4	6
3	RF_OUT		
4	GND1	0	
6	RF_IN	∐1 ∐2 ∐3	4 , 2, 3 sym052

https://www.nxp.com/docs/en/datasheet/BGA2866.pdf

Design of Amp w/ LP Filter





Chip of Discriminator



Ultrafast 3.3 V/5 V Single-Supply SiGe Comparators

ADCMP572/ADCMP573

FEATURES

Data Sheet

3.3 V/5.2 V single-supply operation 150 ps propagation delay 15 ps overdrive and slew rate dispersion 8 GHz equivalent input rise time bandwidth 80 ps minimum pulse width 35 ps typical output rise/fall 10 ps deterministic jitter (DJ) 200 fs random jitter (RJ) On-chip terminations at both input pins Robust inputs with no output phase reversal Resistor-programmable hysteresis Differential latch control Extended industrial -40°C to +125°C temperature range

VTP TERMINATION O-VP NONINVERTING O Q OUTPUT INPUT ADCMP572 CML/ ADCMP573 RSPECL V_N INVERTING O INPUT V_{TN} TERMINATION O 14409-02 O LE INPUT HYS O O LE INPUT Figure 1.

https://www.analog.com/media/en/technical-documentation/data-sheets/ADCMP572_573.pdf

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Development of Carbonless MRPC for MARQ Experiment @ RPC2024

FUNCTIONAL BLOCK DIAGRAM

Design of Discriminator





Figure 5. Propagation Delay vs. Temperature



HRTDC

Streaming HR-TDC on AMANEQ



from upstream (distributer) module

AMANEQ Str-HRTDC

- Input: 64 ch (32+32)
- Timing resolution: $\sim 25 \text{ ps} (\sigma)$
 - · Synchronization precision of MIKUMARI is included
- Data link: IOGbE
 - TCP/IP provided by SiTCP-XG
- **Operation** mode
 - Stand alone mode
 - Sync with MIKUMARI system

Tested in the beam experiments at RCNP Grand **RAIDEN and J-PARC hadron facility**

https://openit.kek.jp/workshop/2023/dsys/presentation/honda.pdf

$$\sigma_{[Pos-Neg]}^2 = 2 * \left[\sigma_{Eletro}^2 + (1-\rho)\sigma_{RPC}^2 \right]$$

- $\sigma_{positive}^2 = \sigma_{RPCP}^2 + \sigma_{EletroP}^2 + \sigma_{ScinP}^2$
- $\sigma_{negative}^2 = \sigma_{RPCN}^2 + \sigma_{EletroN}^2 + \sigma_{ScinN}^2$
- $\sigma_{PosSubNeg}^2 = ?$
- \mathcal{O} σ_{scinP} and σ_{scinN} are fully correlated (same source).
- 2 electronics of positive and negative are independent, but the same size.
- 3 signal of positive and negative are partially correlated/uncorrelated, not sure.

$$\sigma_{PosSubNeg}^{2} = 2 * \sigma_{Eletro}^{2} + [\sigma_{RPCP}^{2} + \sigma_{RPCN}^{2} - 2\rho * \sigma_{RPCN} * \sigma_{RPCP}]$$

where ρ gives the correlation between σ_{RPCN} and σ_{RPCP}

If σ_{RPCN} and σ_{RPCP} are fully correlated

 $\Rightarrow \sigma_{PosSubNeg}^2 = 2 * \sigma_{Eletro}^2$

We can potential know the jitter of electronics if σ_{RPCN} and σ_{RPCP} are fully correlated.

If σ_{RPCN} and σ_{RPCP} are partially correlated with the same size. $\Rightarrow \sigma_{PosSubNeg}^2 = 2 * [\sigma_{Eletro}^2 + (1 - \rho)\sigma_{RPC}^2]$